

**Notice of References Cited**

Application/Control No.

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Applicant(s)/Patent Under  
Reexamination  
LIANG, LIEN-FENG

Examiner

Deborah Yee

Art Unit

1742

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**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-4,345,943	08-1982	Takahashi et al.	75/238
	B	US-			
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	D	US-			
	E	US-			
	F	US-			
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	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

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	N	359016952	01-1984	Japan	Iijima et al.	420/42
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	S					
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**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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